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## **Surface Roughness and Interfacial Slip Boundary Condition for Quartz Crystal Microbalances**

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## Abstract

The response of a quartz crystal microbalance (QCM) is considered using a wave equation for the substrate and the Navier-Stokes equations for a finite liquid layer under a slip boundary condition. It is shown that when the slip length to shear wave penetration depth is small, the first order effect of slip is only present in the frequency response. Importantly, in this approximation the frequency response satisfies an additivity relation with a net response equal to a Kanazawa liquid term plus an additional Sauerbrey “rigid” liquid mass. For the slip length to result in an enhanced frequency decrease compared to a no-slip boundary condition, it is shown that the slip length must be negative so that the slip plane is located on the liquid side of the interface. It is argued that the physical application of such a negative slip length could be to the liquid phase response of a QCM with a completely wetted rough surface. Effectively, the model recovers the starting assumption of additivity used in the trapped mass model for the liquid phase response of a QCM having a rough surface. When applying the slip boundary condition to the rough surface problem, slip is not at a molecular level, but is a formal hydrodynamic boundary condition which relates the response of the QCM to that expected from a QCM with a smooth surface. Finally, possible interpretations of the results in terms of acoustic reflectivity are developed and the potential limitations of the additivity result should vapour trapping occur are discussed.

**Keywords:** Acoustic waves, quartz crystal microbalances, sensors, slip, contact angles, wetting.

## I. Introduction

A quartz crystal microbalance (QCM) responds to immersion in a liquid via changes in its resonant frequency and damping. These energy storage and energy dissipation effects are sensitive probes of the interface between the crystal and the liquid. The interfacial region is defined by the viscous entrainment of liquid within a penetration depth  $\delta = (2\eta_f / \omega\rho_f)^{1/2}$  where  $\eta_f$  is the viscosity,  $\rho_f$  is the density and  $\omega = 2\pi f$  is the angular frequency. It has long been known that a crystal with a rough surface has an excess liquid phase response, primarily in its frequency decrease, compared to that predicted by the Kanazawa and Gordon equation<sup>1-13</sup>. One suggested method of accounting for this response has been to view the response as composed of a Kanazawa term<sup>14</sup> accounting for the entrainment of the liquid plus a Sauerbrey<sup>15</sup> rigid mass type term with the mass being given by the liquid “trapped” within the surface structure of the crystal<sup>1,8,13</sup>. The assumed additivity of these terms has been the starting point of the model and has not been directly derived from any wave equation for the system. It has also been shown experimentally that the state of hydrophobicity/hydrophilicity of the surface of a QCM can influence its response<sup>5,9,11</sup> even when the surface is relatively smooth<sup>9</sup> (i.e. surface features of depth  $< 0.05 \mu\text{m}$ ). The discussion of excess response due to roughness has, at times inevitably, become entangled with the state of wetting of a surface and possible interfacial slip at the molecular level<sup>9-11</sup>. This present report does not argue for or against either a dominantly roughness induced response or a partially molecular slip induced response. However, we believe that whether molecular slip can occur in the liquid phase response of a QCM and whether its effects can be separated from a roughness induced response is a valid issue, particularly when dealing with surfaces chemically modified for biosensing experiments. It is therefore extremely important to recognize

that a slip boundary condition is a precise mathematical condition, which can lead to specific predictions that can be tested against any anomalous response observed in an experiment.

The concept of interfacial slip is precisely defined in terms of a slip boundary condition, which gives a discontinuity between the solid and liquid velocities at the interface<sup>17-19</sup>; earlier attempts at devising models to describe possible molecular slip occurring in QCM's included a complex slip parameter<sup>16</sup> and an interfacial layer model<sup>20</sup>. To create a mathematical relation for a slip boundary condition does not assign a physical origin to the slip parameter. In one sense a slip parameter may be a mechanism to account for a diffuse interface, whilst in another it may relate directly to a discontinuity of the first molecular layer of the liquid. In this article, we consider the relationship between load impedance derived with and without a slip boundary condition. We neither prove nor disprove the existence of molecular slip in the liquid phase QCM response. A key focus of the article is to address the application of the slip boundary condition to model the response when a crystal with a rough surface is immersed in a Newtonian liquid; the use of a slip boundary condition in this situation does not necessarily imply slip is occurring in the first molecular layer of liquid. We show rigorously that under the condition that a rough surface is completely wetted by a liquid, a slip boundary condition can, under appropriate conditions on the size of roughness, result in the additivity of a Kanazawa and Gordon term with a Sauerbrey trapped liquid mass term for the frequency response; to first order the motional resistance, representing dissipation, is independent of the roughness. The model is developed in terms of a liquid layer of finite thickness rather than simply an infinitely deep Newtonian liquid. The mathematical development of this model is given in a

fully self-contained manner in section II with the necessary experimental consequences of the model in sections IIIa and IIIb. Possible limitations in the 1-dimensional nature of the model of the substrate and in extending the additivity to the case of trapped air/vapour in surface features are discussed in the context of acoustic reflectivity of the solid-liquid and solid-air interface in sections IIIc and IIId. The situation of partial penetration of liquid into surface features is relevant for hydrophobic or partially wetting QCM surfaces.

## II. Theory

### *IIa. Wave Equations*

A first principles model of the response of a smooth QCM to loading by a finite liquid layer (fig. 1) can be obtained by setting up an essentially 1-dimensional wave equation for the substrate of thickness  $w$  and the Navier-Stokes equations for the liquid layer of thickness  $d$ . The equations can be solved and boundary conditions applied at the various interfaces to obtain the displacements or speed of motion of both the substrate and the layer. Several routes are then possible to obtain the effect of the layer on the resonant frequency and damping of the substrate. In the first case a load impedance method, which relates the shear stress to the substrate speed at the interface, can be used<sup>21</sup>. Alternatively a perturbation expansion can be adopted about the resonant frequency of the unloaded substrate<sup>22</sup>. Either method is possible, and both should provide the same results, although many experimental studies use the formalism of the load impedance method.

The Navier-Stokes equation for a Newtonian liquid and assuming continuity and incompressibility, has an equation for fluid flow,

$$\frac{\eta_f}{\rho_f} \nabla^2 \underline{v}_f = i\omega \underline{v}_f \quad (1)$$

where  $\rho_f$  is the density of the fluid,  $\eta_f$  is the viscosity of the fluid,  $\underline{v}_f$  is the fluid velocity,  $\omega$  is the angular frequency and a time dependence  $e^{i\omega t}$  has been assumed. The substrate displacement  $\underline{u}_s$  must satisfy the wave equation,

$$\nabla^2 \underline{u}_s = -\frac{\omega^2}{c_s^2} \underline{u}_s \quad (2)$$

where  $c_s = (\mu_s/\rho_s)^{1/2}$  is the intrinsic shear speed of the substrate material determined by its shear modulus  $\mu_s$  and density  $\rho_s$ . Solutions to these equations of motion can be sought using velocity and displacement functions of the form,

$$\underline{v}_f = (v_f(z)e^{i\omega t}, 0, 0) \quad (3)$$

and

$$\underline{u}_s = (u_s(z)e^{i\omega t}, 0, 0) \quad (4)$$

Because the substrate is smooth the displacement, Eq. (4), is essentially 1-dimensional. Substituting Eqs. (3) and (4) into Eqs. (1) and (2) and recognising that the general solutions are composed of exponentials gives general solutions,

$$v_f(z) = A_f \exp(ik_f z) + B_f \exp(-ik_f z) \quad (5)$$

and

$$u_s(z) = A_s \exp(ik_s z) + B_s \exp(-ik_s z) \quad (6)$$

where the  $k$  vectors are given by  $k_f = (-2i)^{1/2}/\delta$  and  $k_s = \omega/c_s$  and the  $A_i$  and  $B_i$  are constants determined by boundary conditions and the fluid wave vector has been written using the shear wave penetration depth  $\delta = (2\eta_f/\omega\rho_f)^{1/2}$ .

To convert from a general solution to a specific solution boundary conditions must be imposed at the upper and lower free surface and at the interface between the substrate and the layer. Only the latter of these conditions depends upon the slip or no-slip boundary condition and we, therefore, first develop the form of the solution using the boundary condition of vanishing shear stress at the upper and lower free surfaces of the substrate-fluid layer system, i.e.

$$\eta_f \left( \frac{\partial v_f}{\partial z} \right)_{z=d} = 0 \quad (7)$$

and

$$\mu_s \left( \frac{\partial u_s}{\partial z} \right)_{z=-w} = 0 \quad (8)$$

Using Eqs. (4) and (5) in Eqs. (7) and (8) determines two of the four constants  $A_f$ ,  $B_f$ ,  $A_s$ , and  $B_s$ , so that the solutions become,

$$v_f(z) = 2A_f \exp\left(\frac{\sqrt{2i}d}{\delta}\right) \cosh\left[\frac{\sqrt{2i}(z-d)}{\delta}\right] \quad (9)$$

and

$$u_s(z) = 2A_s \exp(-ik_s w) \cos[k_s(z+w)] \quad (10)$$

The relationship between the two remaining constants  $A_f$  and  $A_s$  is determined by the boundary condition still to be imposed at the substrate-fluid layer interface. It is interesting to note that due to the complex argument in the cosh(), whether or not a slip boundary condition is chosen, the fluid velocity will have a damped oscillation representing viscous entrainment with a penetration into the (fluid) layer set by the shear wave penetration depth  $\delta$ . The derivations in this section can be extended to



the case of a substrate coated by a viscoelastic layer; both of the cases of slip of a liquid or a solid layer on a QCM surface can then be obtained by taking the appropriate limits. For completeness, the key equations for a derivation for the viscoelastic case are given in appendix A.

### ***I Ib. Surface Mechanical Impedance***

To obtain the usual Kanazawa and Gordon, and Sauerbrey equations we could now develop a perturbation expansion about a vanishing thickness liquid layer. The alternative, we adopt here, is to use the surface mechanical impedance of the film<sup>18,23</sup>,  $Z_L$ , defined by,

$$Z_L = \left[ \frac{F_f}{v_s} \right]_{z=0} \quad (11)$$

where  $F_f$  is the shear force exerted by the film on the substrate per unit area and is given by the shear stress,

$$F_f = -\eta_f \left( \frac{dv_f}{dz} \right)_{z=0} \quad (12)$$

In a linear approximation the relationship between the load impedance and the angular frequency shift and dissipation are given by,

$$\Delta\omega = \frac{-1}{\rho_s w} \text{Im}[Z_L] \quad (13)$$

and

$$\Delta D = \frac{2}{\omega \rho_s w} \text{Re}[Z_L] \quad (14)$$

The dissipation,  $\Delta D$ , can be related directly to the motional resistance,  $R_m$ , and the substrate thickness determines the resonant frequency via  $w=m\pi c_s/\omega$  with  $m=1$  giving

the fundamental frequency of the QCM. Using Eqs. (9)-(12) an expression can be developed for the impedance in the following form that is not specific to whether a slip or no-slip boundary condition is to be applied,

$$Z_L = -i\sqrt{\frac{i\rho_f\eta_f}{\omega}}\left(\frac{A_f}{A_s}\right)\exp\left(ik_s w + \frac{\sqrt{2i}d}{\delta}\right)\left[\frac{\sinh\left(\frac{\sqrt{2i}d}{\delta}\right)}{\cos(k_s w)}\right] \quad (15)$$

Thus, the surface load impedance is proportional to  $A_f/A_s$  so that the sensitivity to the precise boundary condition at the substrate-fluid layer interface enters the impedance through the relationship between  $A_f$  and  $A_s$ . Appendix A gives the analogous results for a finite viscoelastic layer.

### ***IIc. Substrate-Layer Interface Boundary Conditions***

#### ***No-Slip Boundary Condition***

The no-slip condition imposes the condition that fluid velocity and substrate velocity should be equal at the boundary between the substrate and the layer; equivalently the displacements can be matched. Using Eqs. (9) and (10) and setting  $v_f(z=0)=i\omega u_s(z=0)$  gives,

$$A_f^{no\ slip} = i\omega\exp\left(-ik_s w + \frac{\sqrt{2i}d}{\delta}\right)\left[\frac{\cos(k_s w)}{\cosh\left[\frac{\sqrt{2i}d}{\delta}\right]}\right]A_s^{no\ slip} \quad (16)$$

where the superscript *no slip* has been introduced to remind us that the no-slip boundary condition has been used to determine the relationship between the constants  $A_f$  and  $A_s$ . Using Eq. (15) we then obtain the impedance,

$$Z_L^{no\ slip} = \sqrt{i\omega\rho_f\eta_f} \tanh\left[\frac{\sqrt{2i}d}{\delta}\right] \quad (17)$$

### ***Slip Boundary Condition***

In an earlier report we used a slip boundary condition introduced by Rodahl and Kasemo<sup>17</sup> (see also McHale *et al*<sup>18</sup>) which related the mis-match in speeds at the boundary between the substrate and the layer to the shear stress at the boundary, i.e.

$$\chi m_{ML} (v_s(z=0) - v_f(z=0)) = F_f \quad (18)$$

where  $\chi$  is the coefficient of friction between the film and the surface and  $m_{ML}$  is the mass per unit area of a monolayer of the film. In the earlier report<sup>18</sup> we introduced an  $s$  factor defined as  $s=1/\chi m_{ML}$ . In contrast, Ellis and Hayward<sup>19</sup> have recently introduced a slip length  $b$  defined by the boundary condition,

$$v_s(z=0) = v_f(z=-b) \quad (19)$$

Performing a Taylor expansion of Eq. (19) about  $z=0$  gives,

$$v_s(z=0) - v_f(z=0) = -b \left( \frac{dv_f}{dz} \right)_{z=0} \quad (20)$$

and with the definition of  $F_f$  used in Eq. (12) this gives,

$$\frac{\eta_f}{b} [v_s(z=0) - v_f(z=0)] = F_f \quad (21)$$

Comparing Eq. (21) to Eq. (18) we deduce that  $s=b/\eta_f$ . The relationship between the fluid layer velocity gradient extrapolated from the bulk and the slip length  $b$  is shown

diagrammatically in fig. 2. The slip boundary condition Eq. (18) can therefore be regarded as a first order approximation to the slip boundary condition in Eq. (19) so that the two slip boundary conditions are consistent with each other. In the case of a viscoelastic rather than a liquid layer, the equivalent relation for  $s$  is  $s=i\omega b/G_f$ , where  $G_f$  is the complex shear modulus (see appendix B).

Applying the Ellis and Hayward<sup>19</sup> slip boundary condition (Eq. (19)) to Eqs. (9) and (10) gives,

$$A_f^{slip} = i\omega \exp\left(-ik_s w - \frac{\sqrt{2i} d}{\delta}\right) \left[ \frac{\cos(k_s w)}{\cosh\left[\frac{\sqrt{2i}(d+b)}{\delta}\right]} \right] A_s^{slip} \quad (22)$$

which differs from the no-slip case only by a shift of  $d$  by  $b$  in the cosh() term in the denominator of Eq. (22). Using the definition of the surface mechanical impedance we obtain,

$$Z_L^{slip} = \frac{\sqrt{i\omega\rho_f\eta_f} \sinh\left(\frac{\sqrt{2i} d}{\delta}\right)}{\cosh\left(\frac{\sqrt{2i}(d+b)}{\delta}\right)} \quad (23)$$

which reduces to the no-slip result when  $b=0$ .

In the case that the dimensionless combination characterising the influence of slip  $b/\delta$  is small, the cosh() can be expanded as,

$$\cosh\left(\frac{\sqrt{2i}(d+b)}{\delta}\right) \approx \cosh\left(\frac{\sqrt{2i} d}{\delta}\right) \left[ 1 + \frac{\sqrt{2i} b}{\delta} \tanh\left(\frac{\sqrt{2i} d}{\delta}\right) \right] \quad (24)$$

and the impedance, Eq. (23), becomes

$$Z_L^{slip} \approx \frac{\sqrt{i\omega\rho_f\eta_f} \tanh\left(\frac{\sqrt{2i}d}{\delta}\right)}{1 + \frac{\sqrt{2i}b}{\delta} \tanh\left(\frac{\sqrt{2i}d}{\delta}\right)} \quad (25)$$

Eq. (25) can be re-written in the form,

$$Z_L^{slip} = \frac{Z_L^{no\ slip}}{1 + \frac{b}{\eta_f} Z_L^{no\ slip}} \quad (26)$$

The factor  $b/\eta_f$  in the denominator of Eq. (26) is the slip factor  $s$ . We have previously derived Eq. (26) using a harmonic oscillator substrate model coated by a general finite viscoelastic layer and have shown that it can be interpreted using a single-loop feedback model<sup>18</sup>; this equation can also be derived from the general interfacial layer approach of ref [18]. Appendix B gives the analogous results for a viscoelastic layer and hence includes both the solid and liquid limits.

### III. Discussion

#### IIIa. “Liquid” Mass Layer Additivity

The idea of a “rigid” liquid mass added to a Kanazawa type entrained liquid response is implicit with Eq. (26). To show this rigorously we expand Eq. (26)

$$Z_L^{slip} \approx Z_L^{no\ slip} \left( 1 - \frac{b}{\eta_f} Z_L^{no\ slip} \right) \quad (27)$$

and consider the layer to be an infinitely deep Newtonian fluid, so that Eq. (17) gives

$$Z_L^{no\ slip} \approx \sqrt{i\omega\rho_f\eta_f} \quad (28)$$

Since  $(2i)^{1/2} = 1 + i$ , Eq. (27) becomes,

$$Z_L^{slip} \approx (1+i)\sqrt{\frac{\omega\rho_f\eta_f}{2}}\left(1-\frac{(1+i)b}{\eta_f}\sqrt{\frac{\omega\rho_f\eta_f}{2}}\right) \quad (29)$$

which after expanding, grouping terms into real and imaginary and using the definition of the penetration depth gives,

$$Z_L^{slip} \approx \sqrt{\frac{\omega\rho_f\eta_f}{2}}\left[1+i\left(1-\frac{2b}{\delta}\right)\right] \quad (30)$$

Another view of Eq. (30) is that the impedance for an infinitely deep Newtonian liquid using the slip boundary condition, contains the Kanazawa result assuming a no-slip boundary condition plus an additional impedance equal to  $-i\omega\rho_f b$ ; the analogous result for a thin layer of rigid mass is given appendix C. The real part of the impedance, Eq. (30), gives the dissipation due to the liquid and since it does not include a slip correction factor it is relatively insensitive to the slip length in this approximation of small  $b/\delta$ . In contrast, the imaginary part of the impedance, which determines the frequency shift, has a correction factor involving the slip length parameter. Using Eq. (13) and the fundamental resonance condition  $\omega=\pi v_s/\lambda$ , Eq. (30) gives,

$$\left(\frac{\Delta\omega}{\omega}\right)_{slip} \approx \left(\frac{\Delta\omega}{\omega}\right)_{no\ slip}\left(1-\frac{2b}{\delta}\right) \quad (31)$$

where

$$\left(\frac{\Delta\omega}{\omega}\right)_{no\ slip} \approx -\frac{1}{\pi}\sqrt{\frac{\omega\rho_f\eta_f}{2\rho_s\mu_s}} \quad (32)$$

Combining Eq. (32) with the additional factor  $2b/\delta$  occurring in Eq. (31) gives,

$$\left(\frac{\Delta\omega}{\omega}\right)_{additional} \approx \left(-\frac{2b}{\delta}\right)\left(\frac{\Delta\omega}{\omega}\right)_{no\ slip} = \frac{\omega\Delta m_f}{\pi\sqrt{\mu_s\rho_s}} \quad (33)$$

where  $\Delta m_f = b\rho_f$  has been defined. Equation (33) is of the Sauerbrey form for a frequency shift due to a rigid “liquid” mass per unit area deposited on a smooth substrate (quartz crystal); for the case of a thin mass layer given in appendix C the additional term is not of a mass type form and is expected to be a small correction to the Sauerbrey result. Equation (30) predicts a dominant first order effect in the frequency shift rather than the dissipation, but any conversion of the shear motion in the liquid into non-shear motion by, for example, strong roughness or oblique angles in the surface roughness or topography, is likely to generate compressional waves and hence significant damping of the QCM.

One difficulty with the additional mass interpretation of Eq. (33) would be that a positive value for  $b$  would give a frequency increase, whereas the added mass of the Sauerbrey form should give a frequency decrease. A positive value for the slip parameter  $b$  places the slip plane into the solid side of the boundary whilst a negative value places the slip plane out into the liquid side of the boundary (see fig. 2). Diagrammatically, Eqs. (31)-(33) mean that the frequency response of a smooth crystal (substrate) with a slip boundary condition and a negative slip parameter  $b = -|b|$  can be viewed as the sum of the effect of liquid entrainment using a no-slip boundary condition plus a “rigid” mass layer of thickness  $|b|$  and density  $\rho_f$  (see fig. 3). Given some of the confusion that exists in the literature on acoustic wave sensors and slip, it should be emphasised that the development of the equations so far in this work has no physical meaning beyond the mathematical condition of a discontinuity in the substrate and liquid velocities at the solid-liquid interface. Should such a discontinuity occur by some physical mechanism, whether it be a diffuse interface or true molecular slip, the equations so far developed should describe the QCM

response. However, we would emphasise that the result summarized by Eq. (30) is a first order approximation and it may be necessary to use the earlier results prior to the expansions via Eqs. (24) and/or Eq. (27).

### ***IIIb. Negative Slip Length and Trapped Mass***

Taking the slip length to be negative, the effect of Eq. (33) is to enhance the frequency decrease that is observed compared to a system with  $b=0$ . Eq. (30) also shows that the existence of a slip parameter does not, to first order, alter the dissipation of the QCM compared to what would be expected for a crystal immersed in a liquid if the slip parameter vanished. These predictions are consistent with experimental results for immersion of a QCM with a small order rough surface in a wetting liquid, which give an enhanced frequency decrease, but little change in the motional resistance compared to a QCM with a smooth surface<sup>13</sup>. These features in the experimentally observed response correspond to the type of behaviour expected with a negative slip parameter  $b$ . In fact, Martin has previously argued on physical grounds that the effect on the response of a QCM would be primarily in the frequency response and that this can be modelled by using an additivity between the Kanazawa liquid response and a Sauerbrey term representing the trapped mass of liquid (see ref 13 and references therein). The requirement to be satisfied for this to occur, is that the lateral scale of the surface roughness should be less than the penetration depth; otherwise the trapped liquid may not act as a rigid mass. The result in Eqs (31)-(33) would support the additivity argument, and provide an indication of under what circumstances this argument might fail. For larger length scales of roughness, mode conversion and enhanced damping are more likely to occur and the model in section II would not then be appropriate. Moreover, the



results in section II do not necessarily imply that roughness accounts for all experimental data that show anomalous responses. One further requirement to be able to match the application of a slip boundary condition to the response of a rough QCM, to the trapped mass argument for such a QCM is to provide a physical argument for the magnitude and sign of the slip parameter  $b$ .

### ***IIIc. Slip Length and Interfacial Boundary***

The mathematical development for the response of the QCM uses an essentially 1-dimensional model, whereas surface roughness or topographic structuring introduces a two-dimensional aspect to the problem as the thickness of crystal varies with lateral position. In this sub-section we consider how the results for such a QCM surface, for small height variations compared to the crystal thickness, might be interpreted using the results of the essentially 1-dimensional model. Consider fig. 3, but now imagine that the true QCM surface is rough. For simplicity, we show in fig. 3 a dotted line giving a step type “roughness” variation in the position of the QCM surface with equal lengths for the low and high positions (1:1 mark-space ratio). The average position of the surface is the solid horizontal line at  $z=0$  and the surface features vary from  $-A$  to  $+A$ . If we now immerse the QCM then each corrugation of depth  $2A$  would contain trapped liquid. Within the slip boundary condition model we can imagine that this liquid is spread out across each surface feature as a mass layer of thickness  $A$  (fig. 4b). The net effect is that the average position of the interface moves towards the bulk liquid by a distance  $A$ . For this particular geometry, we would argue that the slip parameter  $b$  would therefore be negative and of magnitude  $A$ . A similar argument could be made for any other type of model surface roughness, such as a sinusoidally varying surface, and so be used to determine the slip parameter

magnitude. This interpretation of a negative slip parameter means that the application of the slip boundary condition to this problem of surface roughness does not represent molecular slip, but does show that a slip boundary condition can convert the response of a QCM with a rough surface into an equivalent response for a QCM with a smooth surface. There is nothing in this particular application of the slip boundary condition that would preclude its use to also describe molecular slip, although we would expect that molecular slip would require a positive slip length parameter  $b$ .

### ***IIIId. Acoustic Reflection Considerations***

The slip model matches boundary conditions at the solid-liquid interface and, with a negative  $b$ , merely moves the position of that interface out towards the liquid by a constant amount; this is illustrated in fig. 4a and fig. 4b. When a QCM is in air (fig. 4a) the acoustic wave in the substrate will undergo reflections from both the peaks and troughs of the QCM's corrugated upper surface, thus defining two characteristic resonant cavity lengths. Each of these cavities will define resonances of the crystal and so give two different resonant frequencies. Provided the depth of the surface features is small, adding the waves giving these two resonances will give an average resonant frequency modulated by a low frequency variation. In effect, we could view the QCM's upper surface as having an average centre of reflection so that the substrate thickness is  $w$ . In fig. 4a the path of the acoustic reflection is shown by the dotted vertical arrow and this determines the resonant frequency. When the rough surface is completely wetted the acoustic reflectivity of the upper solid surface of the QCM is the same irrespective of whether the horizontal location ( $x$ -position) corresponds to a peak or a trough in the surface corrugation/roughness. We can

imagine the trapped liquid mass being spread in a uniform film of thickness  $|b|$  across the peaks and troughs of the QCM's upper surface (fig. 4b). This results in an overall and uniform shift in the average centre of acoustic reflectivity towards the bulk liquid phase by an amount  $|b|$ . The path of the acoustic reflection therefore increases as shown schematically by the solid vertical arrow in fig. 4b. An effective increase in the acoustic thickness of the substrate caused by the uniformly spread out trapped mass would be expected to result in a larger resonant half-wavelength and so a lower resonant frequency. This particular conclusion is to some extent speculative, but the change in viewpoint to acoustic reflectivity does help identify a possible implicit assumption in the trapped mass model additivity formula (Eq. (31)).

The explicit limitation on the applicability of Eqs. (31)-(33) to rough surfaces is that  $b/\delta$  be small. However, it is also assumed that the model, is independent of the particular point along the  $x$  direction, i.e. that a damped shear wave oscillation into the liquid begins at the average position of the slip plane no matter what position along the  $x$ -direction is considered. For surface roughness features which are closely spaced this is likely to be true, but as they become further apart it is an assumption likely to fail. A further implicit assumption is that the liquid maintains contact with the surface features across the QCM, i.e. the surface is completely wetted; if it does not the surface reflectivity may become a function of position along the interface. One interesting question that arises is whether vapor trapped in surface features could be accounted for simply by using Eqs. (31)-(33), but modified by reducing the amount of “trapped” liquid<sup>13</sup>. It is not clear from the slip boundary condition model whether the additivity of “liquid” mass will still be valid if this partial penetration by liquid occurs. The slip model matches boundary conditions at the solid-liquid

interface and merely moves the position of that interface out towards the liquid by a constant amount. Figures 4a) and 4b) are an attempt to interpret this movement in terms of acoustic reflections and lead to the identification of an important implicit assumption. If vapor trapping due to incomplete wetting occurs, acoustic reflections from the troughs of the surface features will be due to a solid-air interface whilst those from the peaks will be due to a solid-liquid interface. Since the acoustic reflectivity of the solid-air interface is significantly higher than that of a solid-liquid interface, this may limit the slip model assumption that all positions along the  $x$ -direction see an effective slip parameter of the same value; this could be a particular problem if the reflection was dominated by surface troughs which possessed a solid-vapor interface. In such circumstances, the validity of the additivity result (Eq. (31)) may be questionable and the trapped mass viewpoint may not then be applicable, in some circumstances, to hydrophobic rough surfaces. The potential complexity of this effect is one reason why we have qualified the results in section II of this article to be applicable to the complete wetting case.

#### IV. Conclusion

A slip boundary condition has been implemented via the wave equations for a QCM covered with a finite liquid layer. The response of the QCM on immersion in water assuming a slip length,  $b$ , has been obtained and to first order in  $b/\delta$ , and assuming no mode conversion, it has been shown that the frequency response can be viewed rigorously as a liquid response with an additional component due to a “rigid liquid” mass; to first order the slip boundary condition does not change the dissipation beyond what would be expected from a no-slip boundary condition. For the “rigid liquid” mass to enhance the frequency decrease the slip length must be negative so

that the slip plane is located on the liquid side of the average surface of the QCM. It has been argued that the slip boundary condition with a negative slip length could model the liquid response of a QCM with a rough surface. In this application of the slip boundary condition the results of the model are equivalent to a trapped mass model provided the liquid wets the whole of the rough surface. The possible importance of vapor trapping altering acoustic reflectivity of wetted versus non-wetted portions of the interface has been identified, although it remains unclear whether this could invalidate the trapped mass argument for hydrophobic rough surfaces.

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## Appendix A – Fluid Velocity and Impedance for a Viscoelastic Layer

In this appendix we outline the key changes to Eqs. (1)-(9) required to obtain the fluid velocity when the fluid is regarded as a viscoelastic layer rather than a Newtonian liquid. In the case of a viscoelastic layer, the Navier-Stokes equation for the fluid (Eq. (1)) is modified to

$$\frac{G_f}{i\omega\rho_f}\nabla^2 v_f = i\omega v_f \quad (\text{A1})$$

where  $G_f$  is the complex shear modulus and has liquid and solid limits of  $i\omega\eta_f$  and  $\mu_f$ .

Within the equation for the fluid velocity (Eq. (5)) the wavevector  $k_f$  becomes,

$$k_f = \frac{\sqrt{-2i}}{\bar{\delta}} \quad (\text{A2})$$

where the complex penetration depth is defined by,

$$\bar{\delta} = \sqrt{\frac{2G_f}{i\rho_f\omega^2}} \quad (\text{A3})$$

which in the liquid limit becomes equal to the usual shear wave penetration depth.

The boundary condition Eq. (7) becomes,

$$\frac{G_f}{i\omega\rho_f} \left( \frac{\partial v_f}{\partial z} \right)_{z=d} = 0 \quad (\text{A4})$$

The solution for the fluid velocity (Eq. (9)) becomes

$$v_f(z) = 2A_f \exp\left(\frac{\sqrt{2i}d}{\bar{\delta}}\right) \cosh\left[\frac{\sqrt{2i}(z-d)}{\bar{\delta}}\right] \quad (\text{A5})$$

In the evaluation of surface mechanical impedance the shear stress (Eq. (12)) becomes,

$$F_f = \frac{-G_f}{i\omega} \left( \frac{dv_f}{dz} \right)_{z=0} \quad (\text{A6})$$

so that the general form for the impedance (Eq. (15)) becomes,

$$Z_L = -i \sqrt{\frac{i\rho_f \eta_f}{\omega}} \left( \frac{\bar{\delta}}{\delta} \right) \left( \frac{A_f}{A_s} \right) \exp \left( ik_s w + \frac{\sqrt{2i} d}{\bar{\delta}} \right) \left[ \frac{\sinh \left( \frac{\sqrt{2i} d}{\bar{\delta}} \right)}{\cos(k_s w)} \right] \quad (\text{A7})$$

The key differences in Eq. (A7) compared to Eq. (15) are the replacement of the penetration depth by the complex penetration depth in the  $\exp()$  and  $\sinh()$  factors and the inclusion of a factor which is the ratio of complex penetration depth to penetration depth. Equation (A7) is a general form in the sense that it has not yet had a boundary condition imposed at the substrate-layer interface.

## Appendix B – Slip Length Parameter and a Viscoelastic Layer

In this appendix the effect of the slip boundary condition on a viscoelastic layer is detailed. In the no-slip boundary condition case the relation between the  $A_f$  and  $A_s$  coefficients (Eq. (16)), becomes,

$$A_f^{no\ slip} = i\omega \exp\left(-ik_s w + \frac{\sqrt{2i} d}{\delta}\right) \left[ \frac{\cos(k_s w)}{\cosh\left[\frac{\sqrt{2i} d}{\delta}\right]} \right] A_s^{no\ slip} \quad (B1)$$

which gives the impedance,

$$Z_L^{no\ slip} = \sqrt{i\omega \rho_f \eta_f} \left( \frac{\delta}{\delta} \right) \tanh\left[\frac{\sqrt{2i} d}{\delta}\right] \quad (B2)$$

The equivalent results derived by imposing the Hayward and Ellis<sup>19</sup> slip boundary condition (Eq. (19)) are,

$$A_f^{slip} = i\omega \exp\left(-ik_s w - \frac{\sqrt{2i} d}{\delta}\right) \left[ \frac{\cos(k_s w)}{\cosh\left[\frac{\sqrt{2i}(d+b)}{\delta}\right]} \right] A_s^{slip} \quad (B3)$$

and

$$Z_L^{slip} = \frac{\sqrt{i\omega \rho_f \eta_f} \left( \frac{\delta}{\delta} \right) \sinh\left(\frac{\sqrt{2i} d}{\delta}\right)}{\cosh\left(\frac{\sqrt{2i}(d+b)}{\delta}\right)} \quad (B4)$$

Expanding the denominator we obtain

$$Z_L^{slip} \approx \frac{Z_L^{no\ slip}}{1 + sZ_L^{no\ slip}} \quad (B5)$$



where  $Z_L^{slip}$  and  $Z_L^{no\ slip}$  are defined by Eq. (B2) and (B4) and the  $s$  parameter for the viscoelastic layer is given by  $s=i\omega b/G_f$ ,

$$s = \frac{i\omega b}{G_f} \quad (B6)$$

We note that the McHale *et al*<sup>18</sup> and Ellis and Hayward<sup>19</sup> slip boundary conditions can be related from the Taylor expansion Eq. (20) and the shear stress Eq. (A6) and that doing so gives Eq. (B6).

## Appendix C – Slip Parameter and Thin Rigid Mass Limit

In the case of a thin “rigid” mass layer we find from appendix B,

$$Z_L^{no\ slip} \approx i\omega\rho_f d \quad (C1)$$

which is the Sauerbrey mass response and expanding the denominator in Eq. (B5) gives,

$$Z_L^{slip} \approx i\omega\rho_f d \left[ 1 - \frac{\omega^2 b \rho_f d}{\mu_f} \right] \quad (C2)$$

where  $\mu_f$  is the solid limit of the shear modulus  $G_f$ . Thus, the usual Sauerbrey response is modified by an additional term. To gain insight into the additional term in Eq. (C2), we can rewrite Eq. (C2) as,

$$Z_L^{slip} \approx i\omega\rho_f d \left[ 1 - \left( \frac{2\pi b}{\lambda_f} \right) \left( \frac{2\pi d}{\lambda_f} \right) \right] \quad (C3)$$

where the wavelength in the fluid has been defined as,

$$\lambda_f = \frac{2\pi}{\omega} \sqrt{\frac{\mu_f}{\rho_f}} \quad (C4)$$

For small slip length and layer thickness compared to the wavelength (Eq. (C4)), Eq. (C3) shows that the correction to the Sauerbrey equation is small.

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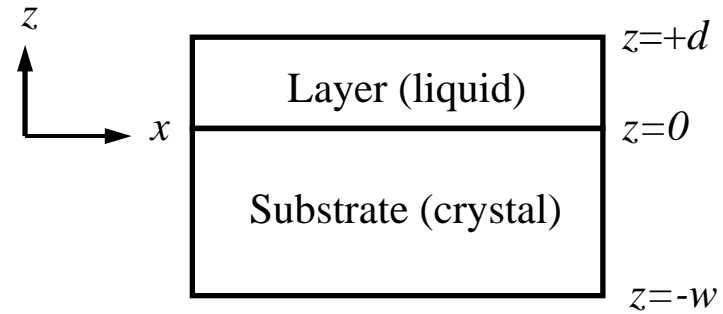
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## Figure Captions

- Figure 1 Definition of axes for quartz crystal substrate with a liquid overlayer.
- Figure 2 Extrapolation of fluid speed gradient from the bulk liquid and the relationship to the slip parameter  $b$ .
- Figure 3 Diagrammatic interpretation of Eqs. (31)-(33). The frequency response of a smooth QCM to immersion in water is treated by the slip boundary condition as a perfect liquid entrainment by a smooth crystal with a no-slip boundary condition plus an additional component equal to a layer of “rigid water” of thickness  $|b|$ . The dotted lines indicate a hypothetical “rough” surface whose average position lies at  $z=0$ .
- Figure 4 Trapped mass viewed as a movement of the average centre of reflection of the QCMs upper surface. a) The unloaded QCM has a resonant frequency determined by the acoustic reflection shown the dotted arrow, b) the trapped liquid mass in the surface features is viewed as increasing the thickness of the substrate at both the trough and crest positions of the roughness by an equal amount  $b$  and so increasing the effective reflection path by  $|b|$  as shown by the solid arrow.

McHale *et al*, “Surface Roughness and Interfacial Slip Boundary Condition for Quartz Crystal Microbalances”

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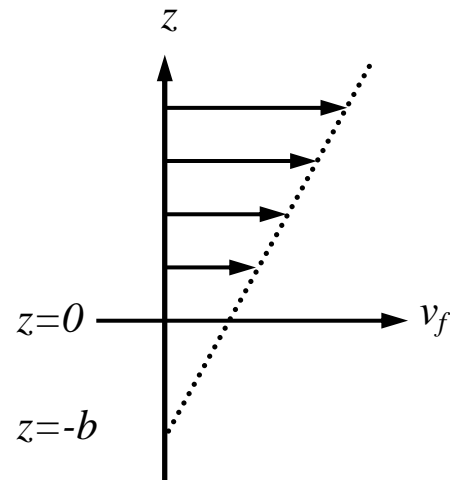


Figure 3 Diagrammatic interpretation of Eqs. (31)-(33). The frequency response of a smooth QCM to immersion in water is treated by the slip boundary condition as a perfect liquid entrainment by a smooth crystal with a no-slip boundary condition plus an additional component equal to a layer of “rigid water” of thickness  $|b|$ . The dotted lines indicate a hypothetical “rough” surface whose average position lies at  $z=0$ .

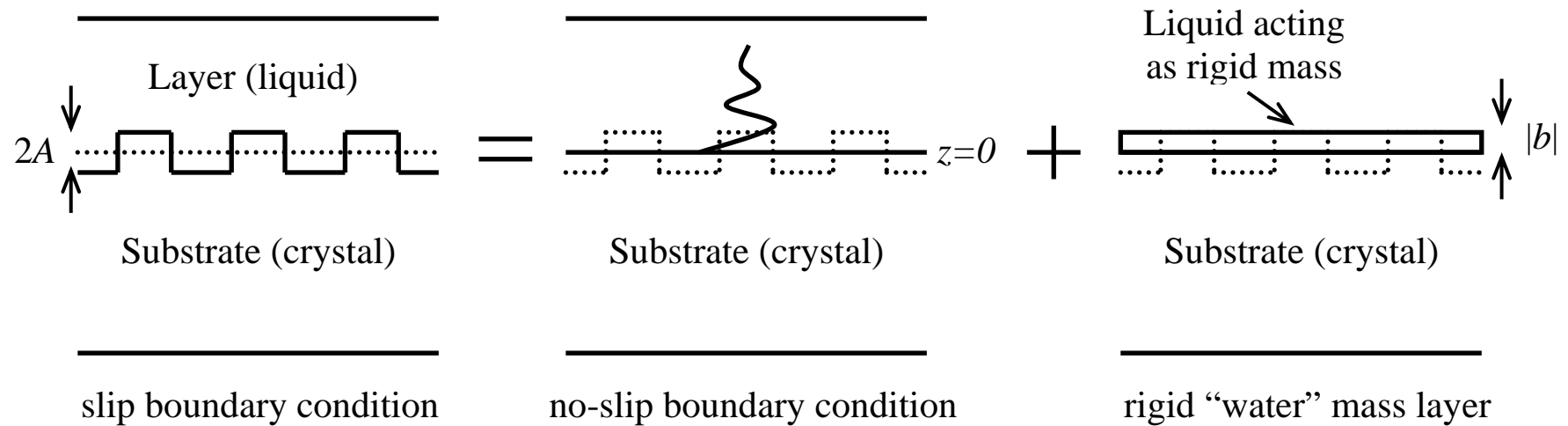




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